



PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

NEW Atty. Dkt. No.: 2775-001

Elwin M. BEATY et al.

OLD Atty. Dkt. No.: 2371

Appln. No.: 09/351,892

Group Art Unit: 2621

Filed: July 13, 1999

Examiner: S. Chawan

Title: METHOD AND APPARATUS FOR THREE
DIMENSIONAL INSPECTION OF
ELECTRONIC COMPONENTS

* * * * *
AMENDMENT UNDER 37 C.F.R. § 1.111
* * * * *

Mail Stop RCE
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

RECEIVED

MAY 29 2003

Technology Center 2600

Dear Sir:

In reply to the Office Action mailed December 23, 2002, the period for reply having been extended by petition to May 23, 2003, and pursuant to the filing herewith of a Request for Continued Examination, please amend the above-identified patent application as follows:

IN THE SPECIFICATION:

Amend the paragraphs from page 6, line 12 through page 7, line 10 to read as follows:

B1 The invention further provides for using a part definition file that contains measurement values for an ideal part, calculating an expected position for each lead of the part for a

Date: May 23, 2003